

FCC, ISED - TEST REPORT

Report Number : **66.790.20.0071.01R1** Date of Issue: 2021-03-16

Model : 200178005KF

Product Type : GEOX CONNNECT

Applicant : Geox SpA

Address : Via Feltrina Centro 16 Montebelluna TV 31044 Italy

Manufacturer : TENNYSON ELECTRONIC (SHEN ZHEN) CO., LTD.

Factory : TENNYSON ELECTRONIC (SHEN ZHEN) CO., LTD.

Address : 3&4/F,Bldg D, Tian Run Zhi Neng Chuang Xin Science Park, Jiuwei 1st Road, Hangcheng Street, Baoan Distric, Shenzhen, China.

Test Result : ☒ **Positive** ☐ **Negative**



Total pages including
Appendices : 49

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1 Table of Contents

1	Table of Contents	2
2	Details about the Test Laboratory	3
3	Description of the Equipment Under Test	4
4	Summary of Test Standards	5
5	Summary of Test Results	6
6	General Remarks	7
7	Test Setups	8
8	Systems test configuration	9
9	Technical Requirement	10
9.1	Conducted Emission	10
	Conducted peak output power	13
9.2	20 dB bandwidth and 99% Occupied Bandwidth	17
9.3	Carrier Frequency Separation	24
9.4	Number of hopping frequencies	26
9.5	Dwell Time	27
9.6	Spurious RF conducted emissions	30
9.7	Band edge testing	36
9.8	Spurious radiated emissions for transmitter	40
10	Test Equipment List	48
11	System Measurement Uncertainty	49

2 Details about the Test Laboratory

Details about the Test Laboratory

Company name: TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch
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Road 2, Nanshan District
Shenzhen 518052
P.R. China

Telephone: 86 755 8828 6998
Fax: 86 755 828 5299

FCC Registration Number: 514049

IC Registration Number: 10320A

3 Description of the Equipment Under Test

Product:	GEOX CONNNECT
Model no.:	200178005KF
Brand Name:	GEOX
FCC ID:	2AQ7N200178005KF
IC:	24328-200178005KF
Options and accessories:	
Input Rating:	5.0 Vdc for adapter, 3.7Vdc battery, 1500mAh, 5.55Wh
RF Transmission Frequency:	2402MHz-2480MHz
No. of Operated Channel:	79
Modulation:	GFSK, $\pi/4$ -DQPSK
Antenna Type:	PCB antenna
Max Antenna Gain:	-0.58dBi
Description of the EUT:	The Equipment Under Test (EUT) is GEOX CONNNECT with Bluetooth function operated at 2.402-2.48GHz.
PMN:	GEOX CONNNECT
HVIN:	200178005KF

4 Summary of Test Standards

Test Standards	
FCC Part 15 Subpart C 10-1-2020 Edition	PART 15 - RADIO FREQUENCY DEVICES Subpart C - Intentional Radiators
RSS-Gen Issue 5, Amendment 2, February 2021	General Requirements and Information for the Certification of Radio Apparatus
RSS-247 Issue 2 February 2017	Digital Transmission Systems (DTSS), Frequency Hopping Systems (FHSS) and License-Exempt Local Area Network (LE-LAN) Devices

All the test methods were according to KDB 558074 D01 v05r02 and Public Notice DA 00-705 - Frequency Hopper Spread Spectrum Test Procedure released by FCC on March 30, 2000 and ANSI C63.10-2013.

5 Summary of Test Results

Technical Requirements			
FCC Part 15 Subpart C, RSS-Gen, RSS-247			
Test Condition		Pages	Test Result
15.207	Conducted emission AC power port	10	Pass
RSS-GEN 8.8			
15.247(b)(1)	Conducted peak output power	10	Pass
RSS-247 5.4(d)			
15.247(e)	Power spectral density	--	N/A
RSS-247 5.2(b)			
15.247(a)(2)	6dB bandwidth	--	N/A
RSS-247 5.2(a)			
15.247(a)(2)	20dB bandwidth and 99% Occupied Bandwidth	17	Pass
RSS-247 5.2(a)			
15.247(a)(1)	Min. of Hopping Channel Carrier Frequency Separation	24	Pass
RSS-247 5.1(b)			
15.247(a)(1)(iii)	Min number of hopping frequencies	26	Pass
RSS-247 5.1(d)			
15.247(a)(1)(iii)	Dwell Time - Average Time of Occupancy	27	Pass
RSS-247 5.1(d)			
15.247(d)	Spurious RF conducted emissions	30	Pass
RSS-247 5.5			
15.247(d)	Band edge	35	Pass
RSS-247 5.5			
15.247(d) & 15.209 & 15.205	Spurious radiated emissions for transmitter and receiver	40	Pass
RSS-GEN 8.9 & RSS-247 5.5			
15.203	Antenna requirement	See note 2	Pass
RSS-247 5.5 & RSS-Gen 6.8			

Note 1: N/A=Not Applicable.

Note 2: The EUT uses an PCB antenna, which gain is -0.58dBi. It is considered sufficiently to comply with the provisions of this section.

6 General Remarks

Remarks

This submittal(s) (test report) is intended for FCC ID: 2AQ7N200178005KF and complies with Section 15.207, 15.209, 15.247 of the FCC Part 15, Subpart C rules.
This submittal(s) (test report) is intended for IC: 24328-200178005KF, complies with RSS-247 and RSS-Gen rules.
This is report for Bluetooth BDR+EDR only.

SUMMARY:

All tests according to the regulations cited on page 6 were

☒ - Performed

☐ - **Not** Performed

The Equipment Under Test

☒ - **Fulfills** the general approval requirements.

☐ - **Does not** fulfill the general approval requirements.

Sample Received Date: January 15, 2021

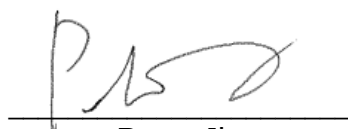
Testing Start Date: March 2, 2021

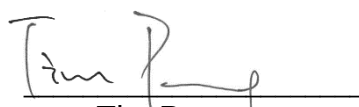
Testing End Date: March 13, 2021

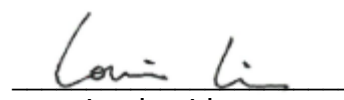
Reviewed by:

Prepared by:

Tested by:

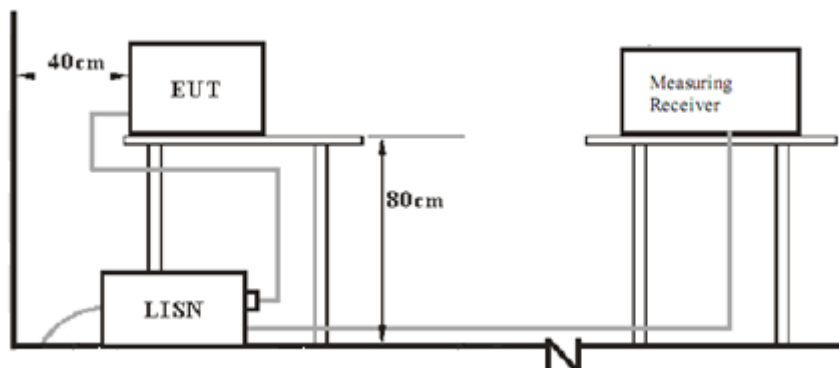

Peter Jia
Reviewer


Tim Pang
Project Engineer

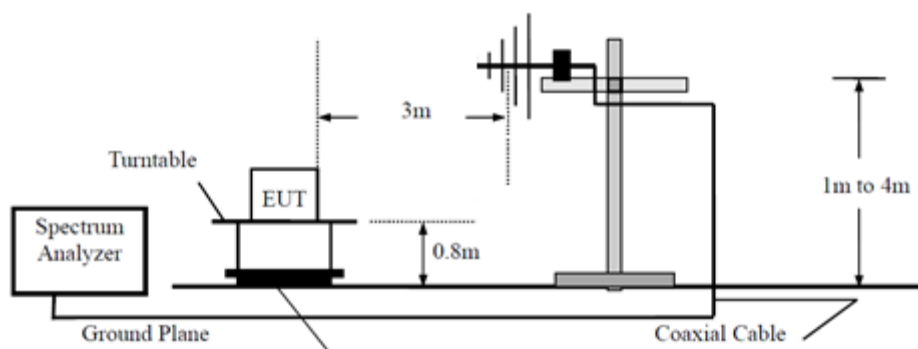

Louise Liu
Test Engineer

7 Test Setups

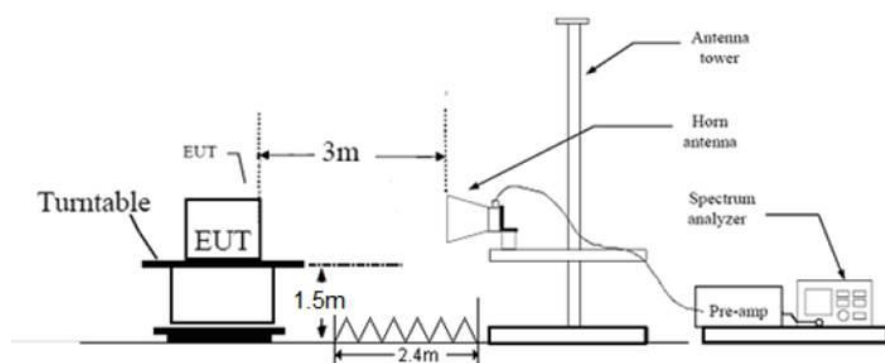
7.1 AC Power Line Conducted Emission test setups



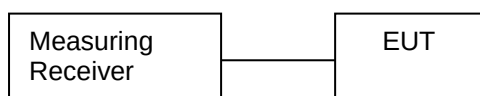
7.2 Radiated test setups Below 1GHz



Above 1GHz



7.2 Conducted RF test setups



8 Systems test configuration

Auxiliary Equipment Used during Test:

DESCRIPTION	MANUFACTURER	MODEL NO.	S/N
Notebook	lenovo	X220	---
Sofeware	---	FCC Assist	

9 Technical Requirement

9.1 Conducted Emission

Test Method

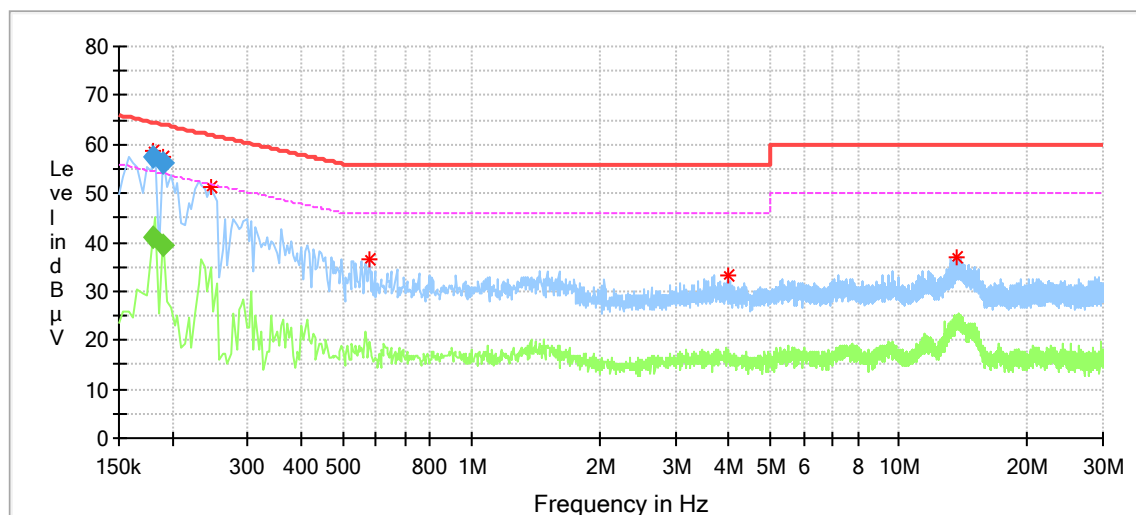
1. The EUT was placed on a table, which is 0.8m above ground plane
2. The power line of the EUT is connected to the AC mains through a Artificial Mains Network (A.M.N.).
3. Maximum procedure was performed to ensure EUT compliance
4. A EMI test receiver is used to test the emissions from both sides of AC line

Limit

Frequency MHz	QP Limit dB μ V	AV Limit dB μ V
0.150-0.500	66-56*	56-46*
0.500-5	56	46
5-30	60	50

Decreasing linearly with logarithm of the frequency

Product Type : GEOX CONNNECT
 M/N : 200178005KF
 Operating Condition : Charging+ BT Link
 Test Specification : Line
 Comment : 120VAC (Supplied by computer)



Final_Result

Frequency (MHz)	QuasiPeak (dBµV)	Average (dBµV)	Limit (dBµV)	Margin (dB)	Line	Corr. (dB)
0.181000	---	41.14	54.60	13.46	L1	9.64
0.181000	57.24	---	64.60	7.36	L1	9.64
0.190000	---	39.41	54.24	14.82	L1	9.64
0.190000	56.24	---	64.24	8.00	L1	9.64

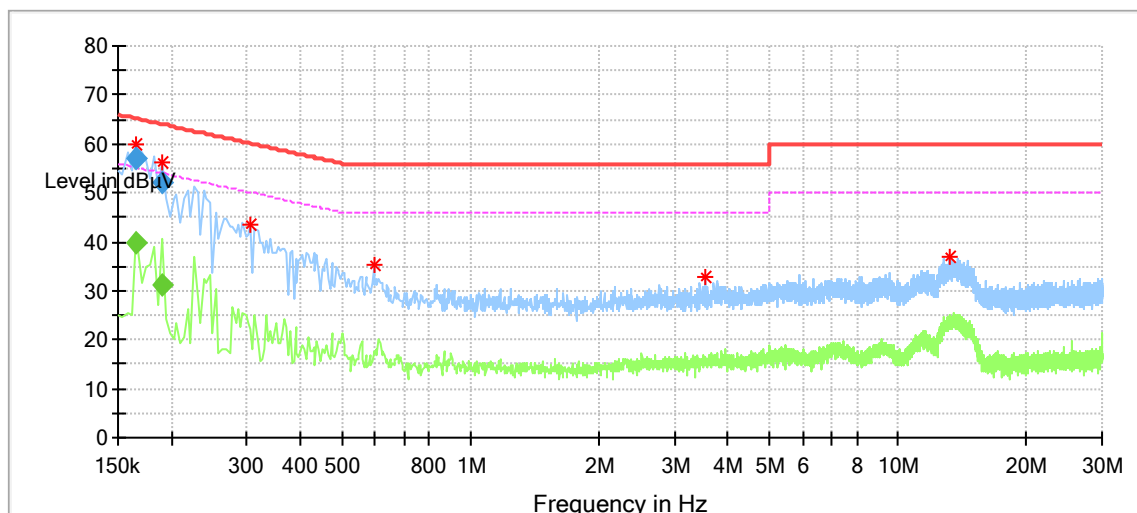
Remark:

Level=Reading Level + Correction Factor

Correction Factor=Cable Loss + LISN Factor

(The Reading Level is recorded by software which is not shown in the sheet)

Product Type : GEOX CONNECT
 M/N : 200178005KF
 Operating Condition : Charging+ BT Link
 Test Specification : Neutral
 Comment : 120VAC (Supplied by computer)



Final_Result

Frequency (MHz)	QuasiPeak (dBµV)	Average (dBµV)	Limit (dBµV)	Margin (dB)	Line	Corr. (dB)
0.166000	---	39.95	54.94	14.99	N	9.62
0.166000	56.85	---	64.94	8.08	N	9.62
0.189500	---	31.12	54.06	22.94	N	9.62
0.189500	51.95	---	64.06	12.11	N	9.62

Remark:

Level=Reading Level + Correction Factor

Correction Factor=Cable Loss + LISN Factor

(The Reading Level is recorded by software which is not shown in the sheet)

Conducted peak output power

Test Method

1. Use the following spectrum analyzer settings:
Span = approximately 5 times the 20dB bandwidth, centered on a hopping channel
RBW > the 20dB bandwidth of the emission being measured, VBW ≥ RBW,
Sweep = auto, Detector function = peak, Trace = max hold
2. Add a correction factor to the display.
3. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power

Limits

conducted peak output power limit as below:

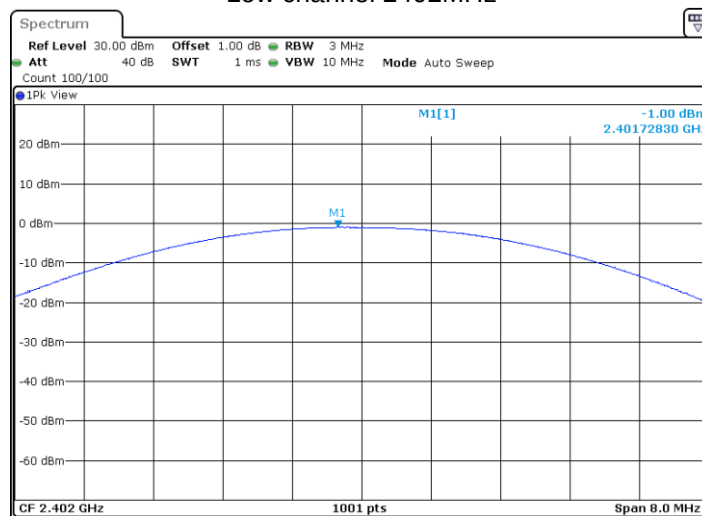
Frequency Range MHz	Limit W	Limit dBm
2400-2483.5	≤1	≤30

Conducted peak output power

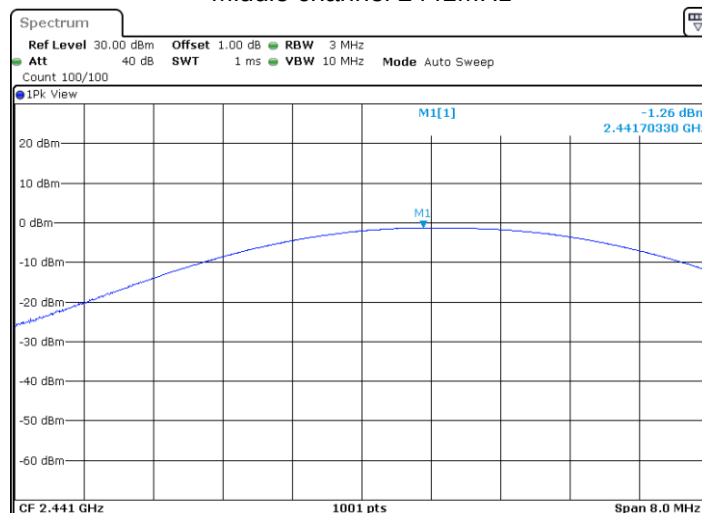
Bluetooth Mode GFSK modulation Test Result

Frequency MHz	Conducted Peak Output Power dBm	EIRP dBm	Result
Low channel 2402MHz	-1.00	-1.58	Pass
Middle channel 2441MHz	-1.26	-1.84	Pass
High channel 2480MHz	-1.90	-2.48	Pass

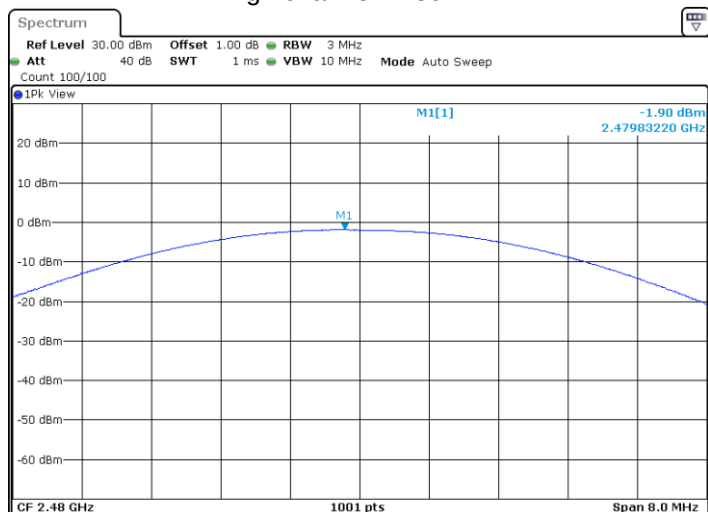
Low channel 2402MHz



Middle channel 2441MHz



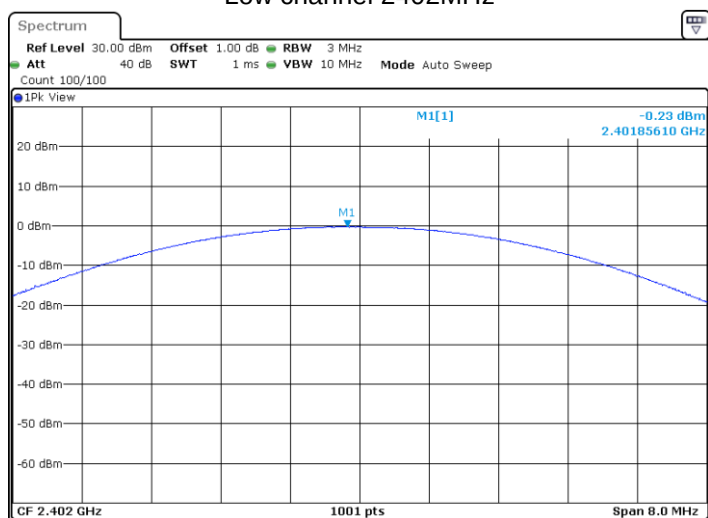
High channel 2480MHz



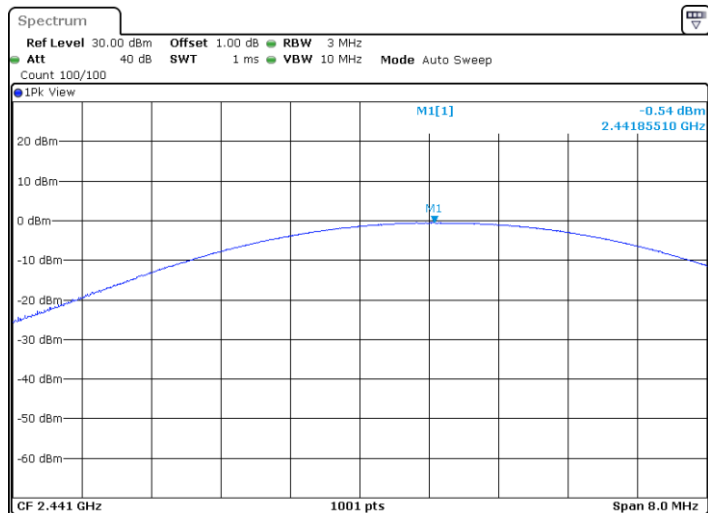
Bluetooth Mode $\pi/4$ -DQPSK modulation Test Result

Frequency MHz	Conducted Peak Output Power dBm	EIRP dBm	Result
Low channel 2402MHz	-0.23	-0.81	Pass
Middle channel 2441MHz	-0.54	-1.12	Pass
High channel 2480MHz	-1.18	-1.76	Pass

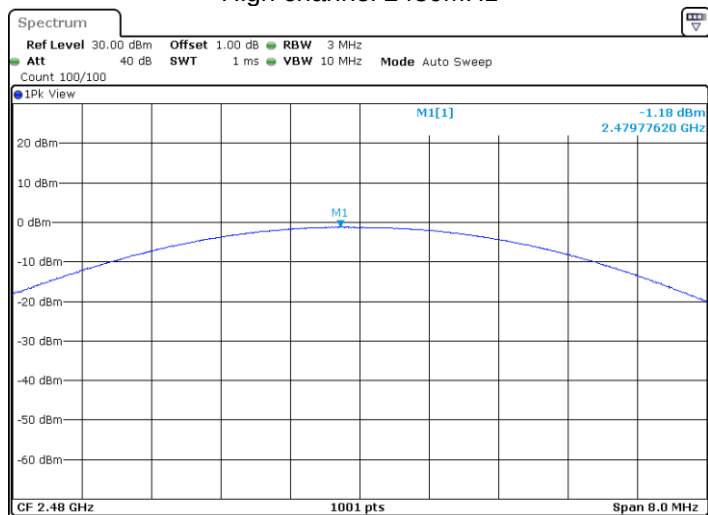
Low channel 2402MHz



Middle channel 2441MHz



High channel 2480MHz



9.2 20 dB bandwidth and 99% Occupied Bandwidth

Test Method

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
3. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
4. Repeat above procedures until all frequencies measured were complete.

Limit

Limit [kHz]

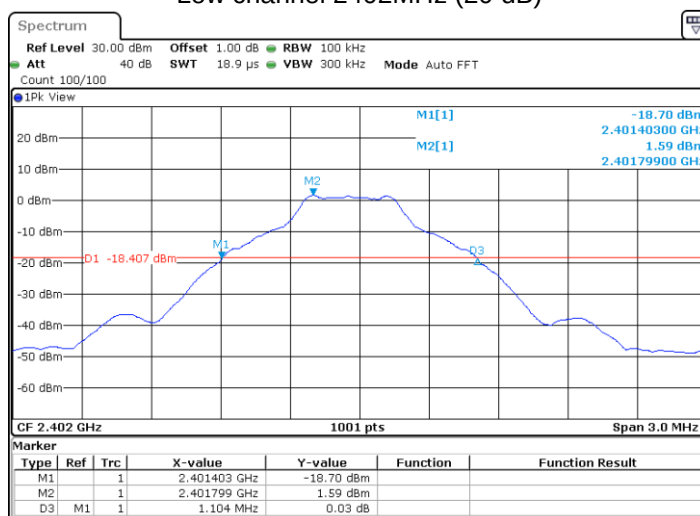
N/A

20 dB bandwidth and 99% Occupied Bandwidth

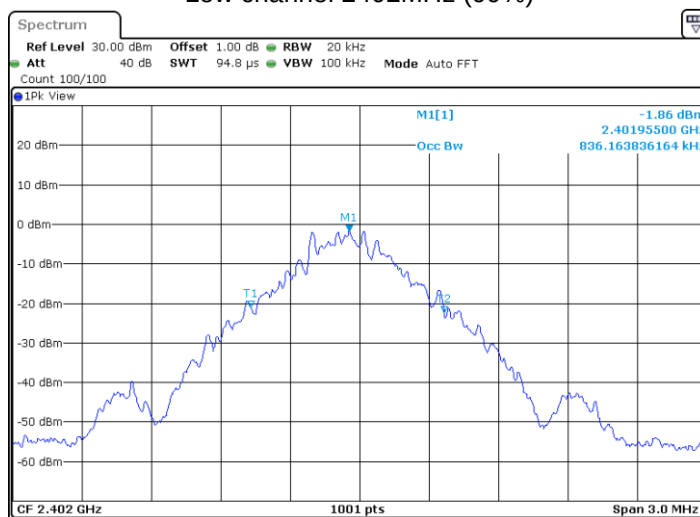
Bluetooth Mode GFSK Modulation test result

Frequency MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Limit kHz	Result
2402	1104	836	--	Pass
2441	1104	836	--	Pass
2480	1104	839	--	Pass

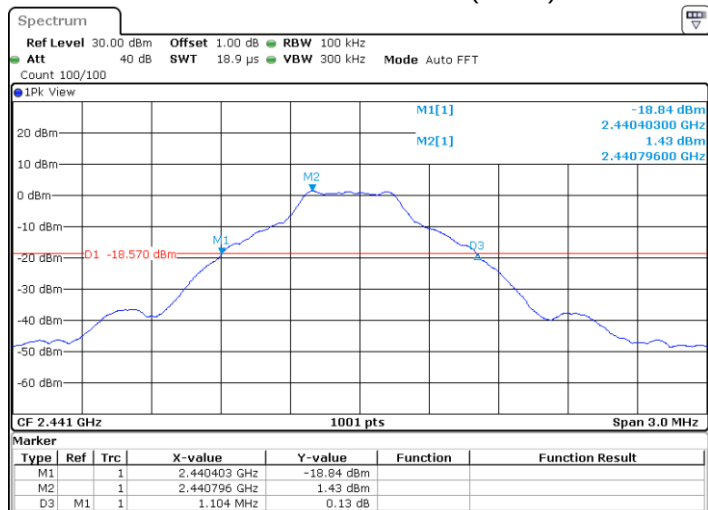
Low channel 2402MHz (20 dB)



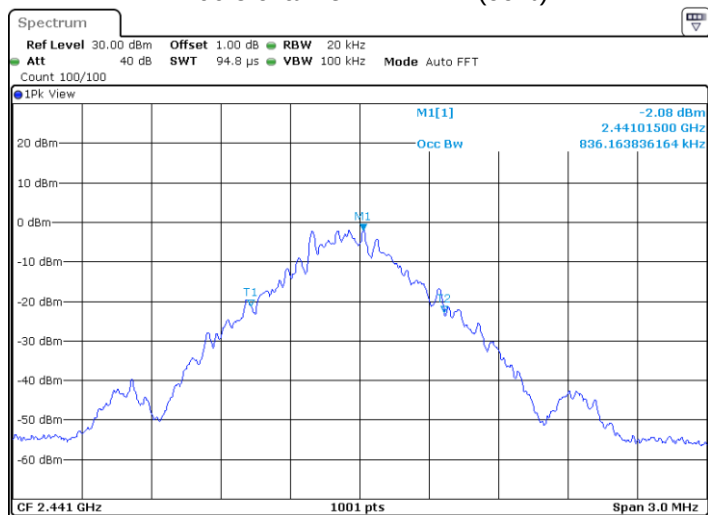
Low channel 2402MHz (99%)



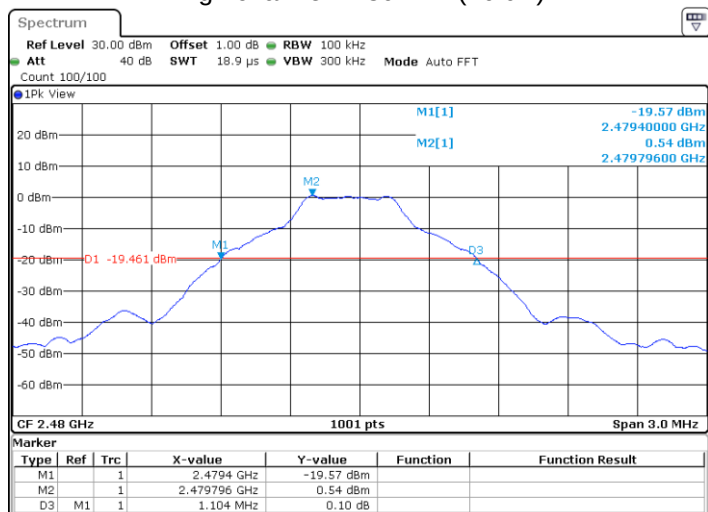
Middle channel 2441MHz (20 dB)



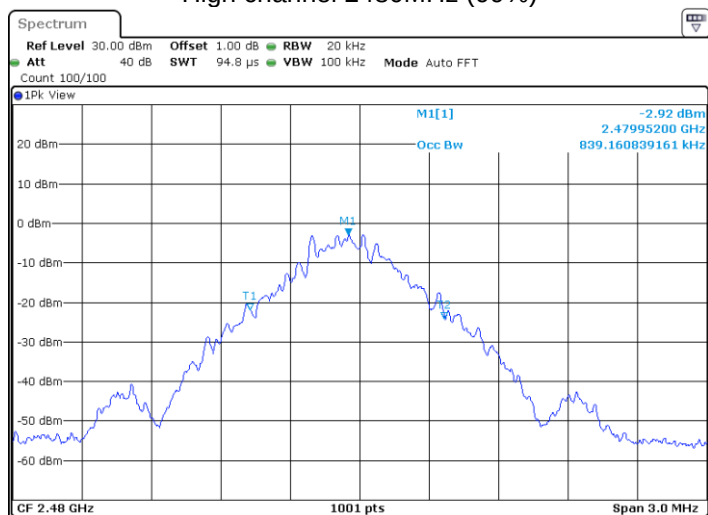
Middle channel 2441MHz (99%)



High channel 2480MHz (20 dB)



High channel 2480MHz (99%)

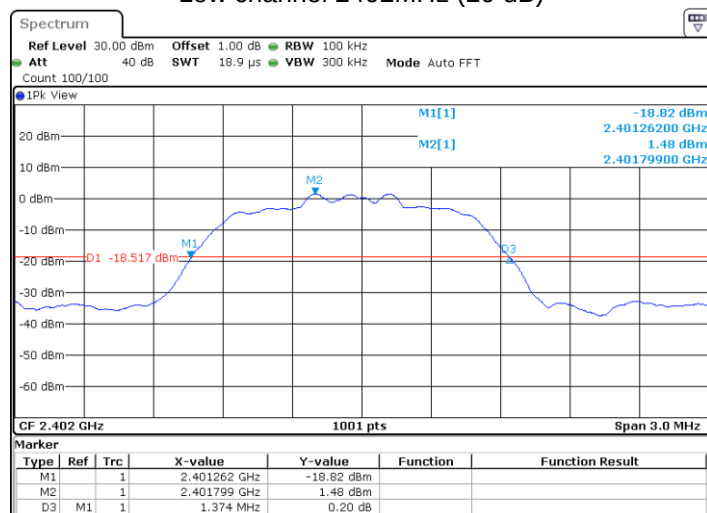


20 dB bandwidth and 99% Occupied Bandwidth

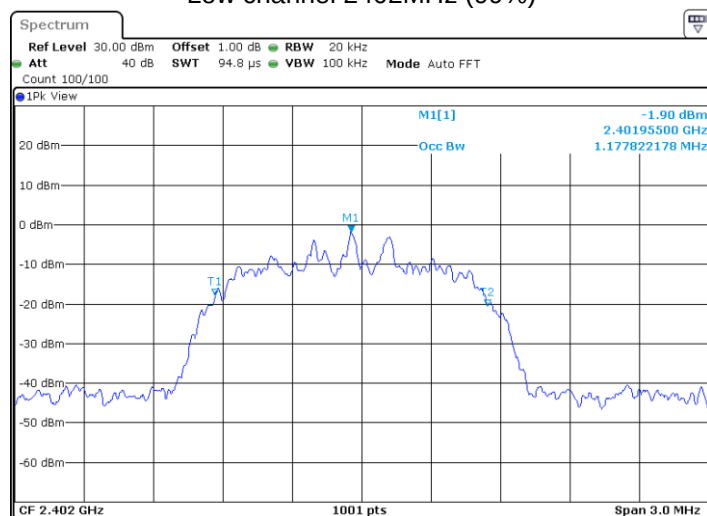
Bluetooth Mode $\pi/4$ -DQPSK Modulation test result

Frequency MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Limit kHz	Result
2402	1374	1178	--	Pass
2441	1374	1184	--	Pass
2480	1377	1184	--	Pass

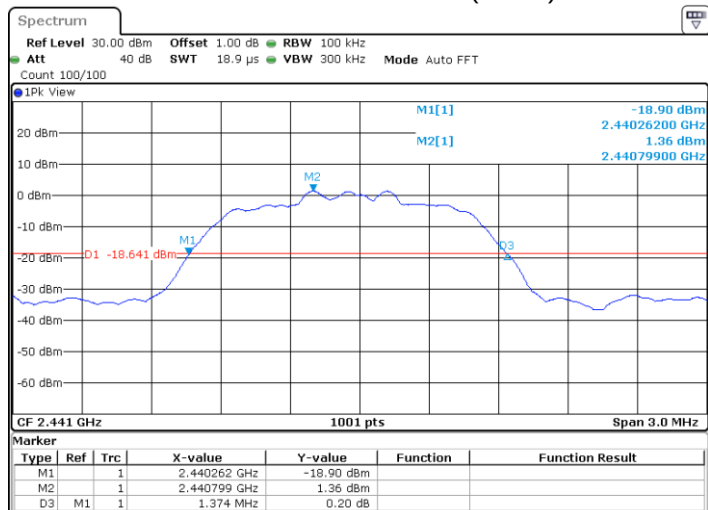
Low channel 2402MHz (20 dB)



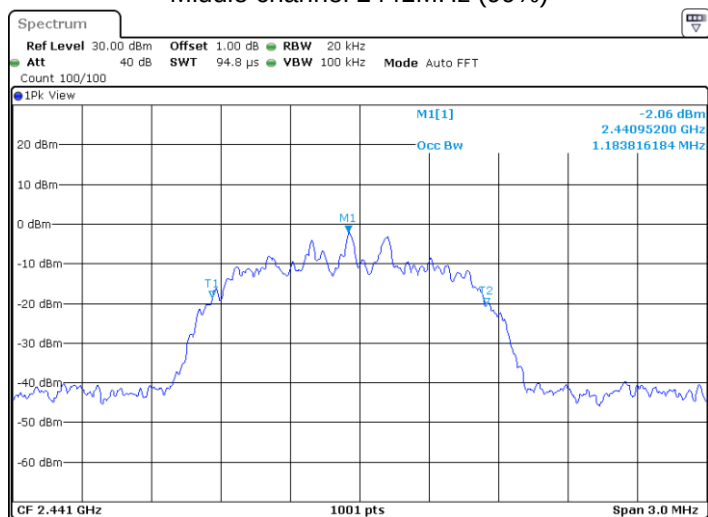
Low channel 2402MHz (99%)



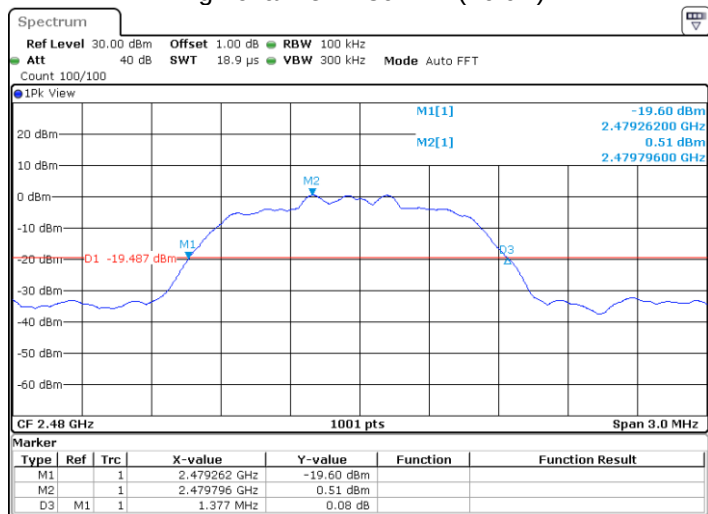
Middle channel 2441MHz (20 dB)



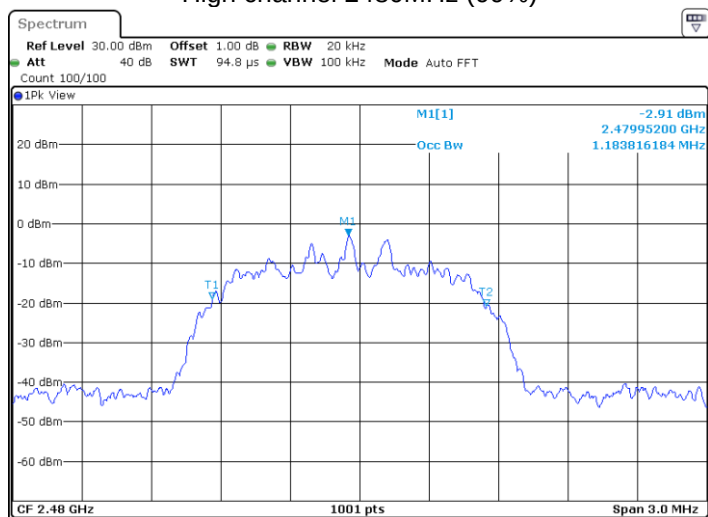
Middle channel 2441MHz (99%)



High channel 2480MHz (20 dB)



High channel 2480MHz (99%)



9.3 Carrier Frequency Separation

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peaks of two adjacent channels, $RBW \geq 1\%$ of the span, $VBW \geq RBW$, Sweep = auto, Detector function = peak
2. By using the Max-Hold function record the separation of two adjacent channels.
3. Measure the frequency difference of these two adjacent channels by spectrum analyzer marker function.
4. Repeat above procedures until all frequencies measured were complete.

Limit

Limit kHz
$\geq 25\text{kHz}$ or $2/3$ of the 20 dB bandwidth which is greater

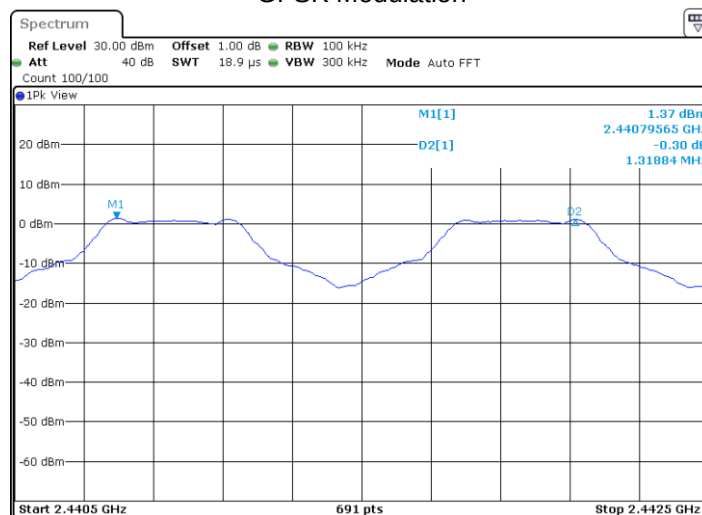
Carrier Frequency Separation

Test result: The measurement was performed with the typical configuration (normal hopping status), here GFSK modulation mode was used to show compliance.

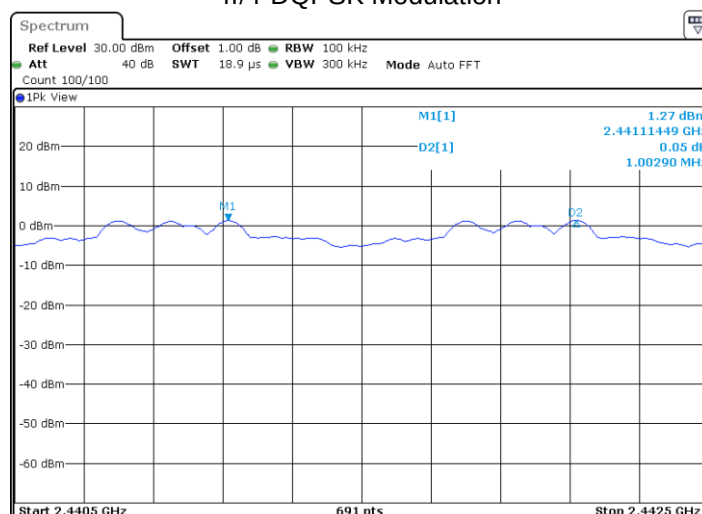
Test result

Test Mode	Channel	Result MHz	Limit(MHz)	Verdict
DH5	Hop	1.319	≥ 0.736	PASS
2DH5	Hop	1.003	≥ 0.916	PASS

GFSK Modulation



$\pi/4$ -DQPSK Modulation



9.4 Number of hopping frequencies

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peaks of two adjacent channels, $RBW \geq 1\%$ of the span, $VBW \geq RBW$, Sweep = auto, Detector function = peak
2. Set the spectrum analyzer on Max-Hold Mode, and then keep the EUT in hopping mode.
3. Record all the signals from each channel until each one has been recorded.
4. Repeat above procedures until all frequencies measured were complete.

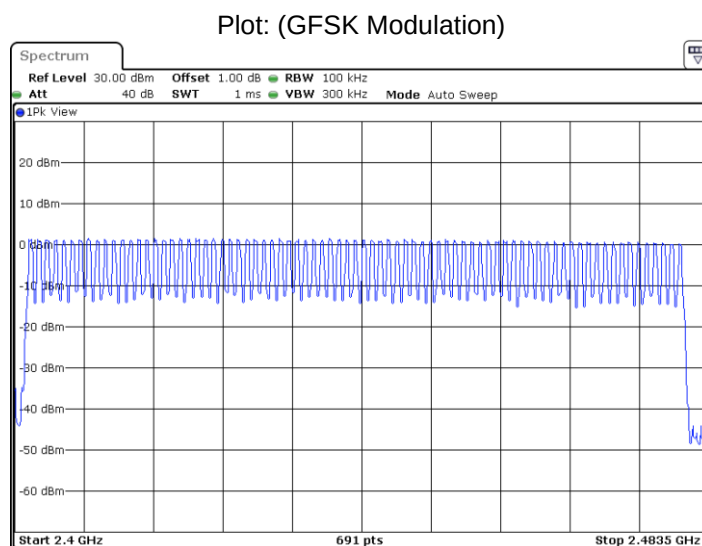
Limit

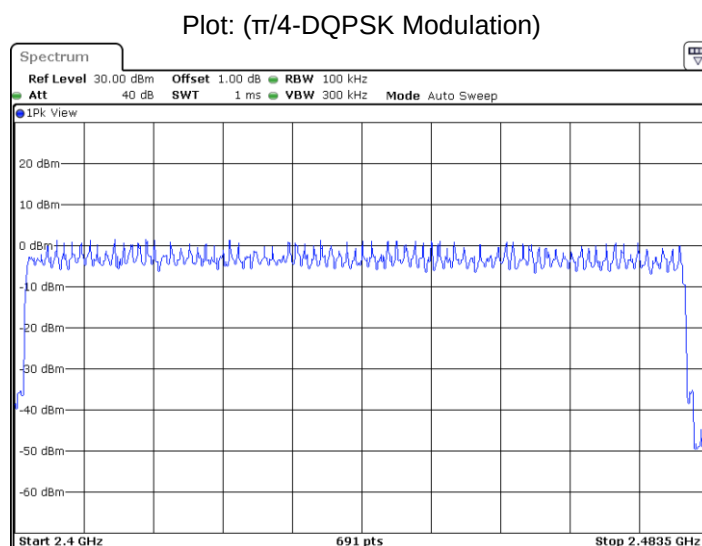
$$\frac{\text{Limit number}}{\geq 15}$$

Number of hopping frequencies

Test result: The measurement was performed with the typical configuration (normal hopping status), and the total hopping channels is constant for the all modulation mode according with the Bluetooth Core Specification. Here GFSK and $\pi/4$ -DQPSK modulation mode was used to show compliance.

Number of hopping frequencies	Result
79	Pass





9.5 Dwell Time

Test Method

1. Connect EUT antenna terminal to the spectrum analyzer with a low loss cable.
Equipment mode: Spectrum analyzer
2. RBW: 1MHz; VBW: 1MHz; SPAN: Zero Span
3. Adjust the center frequency of spectrum analyzer on any frequency be measured.
4. Measure the Dwell Time by spectrum analyzer Marker function.
5. Repeat above procedures until all frequencies measured were complete.

Limit

The average time of occupancy on any frequency shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Dwell Time

Dwell time

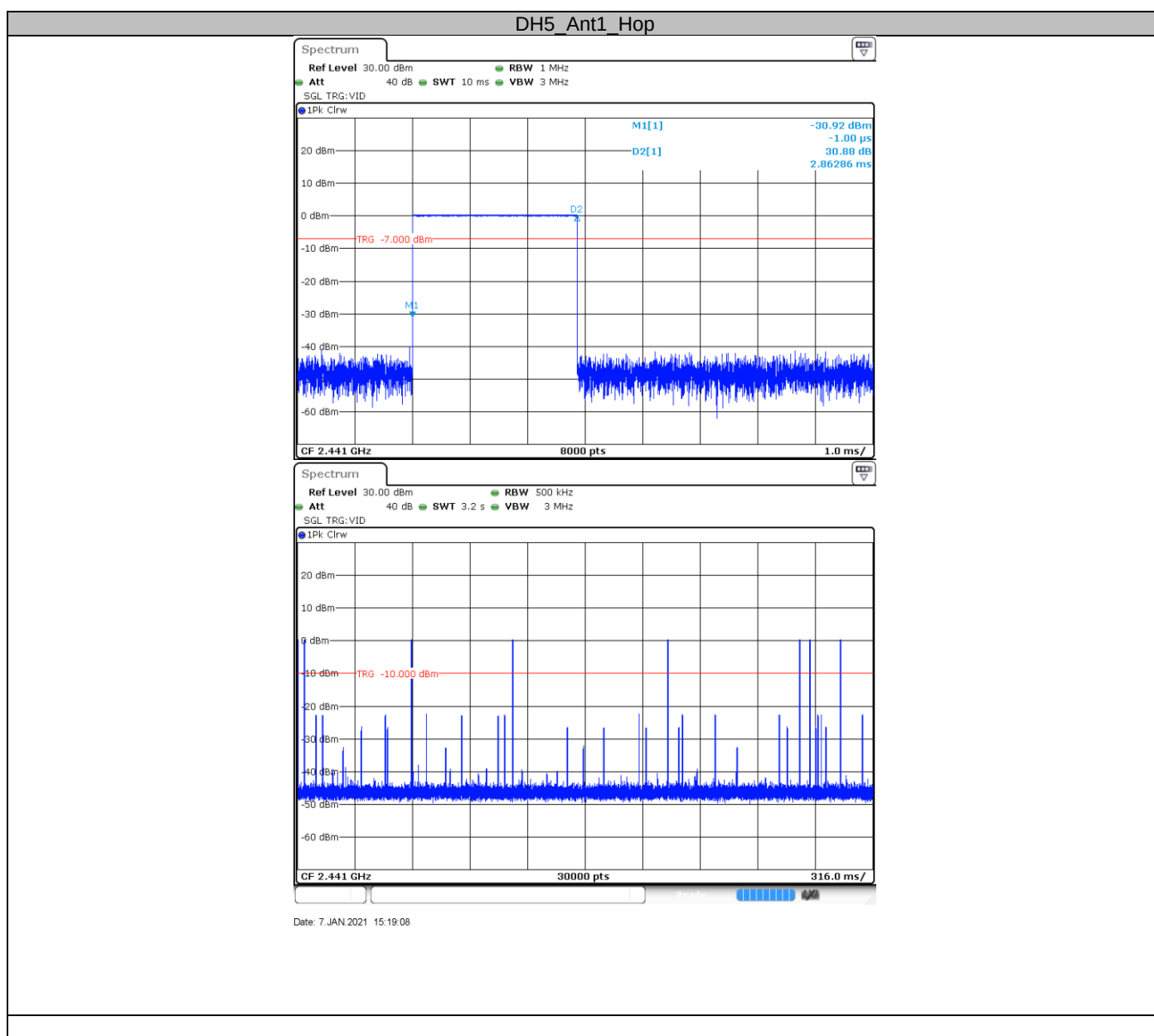
The maximum dwell time shall be 0.4 s.

According to the Bluetooth Core Specification, the worse result (DH5 mode) was reported to show compliance.

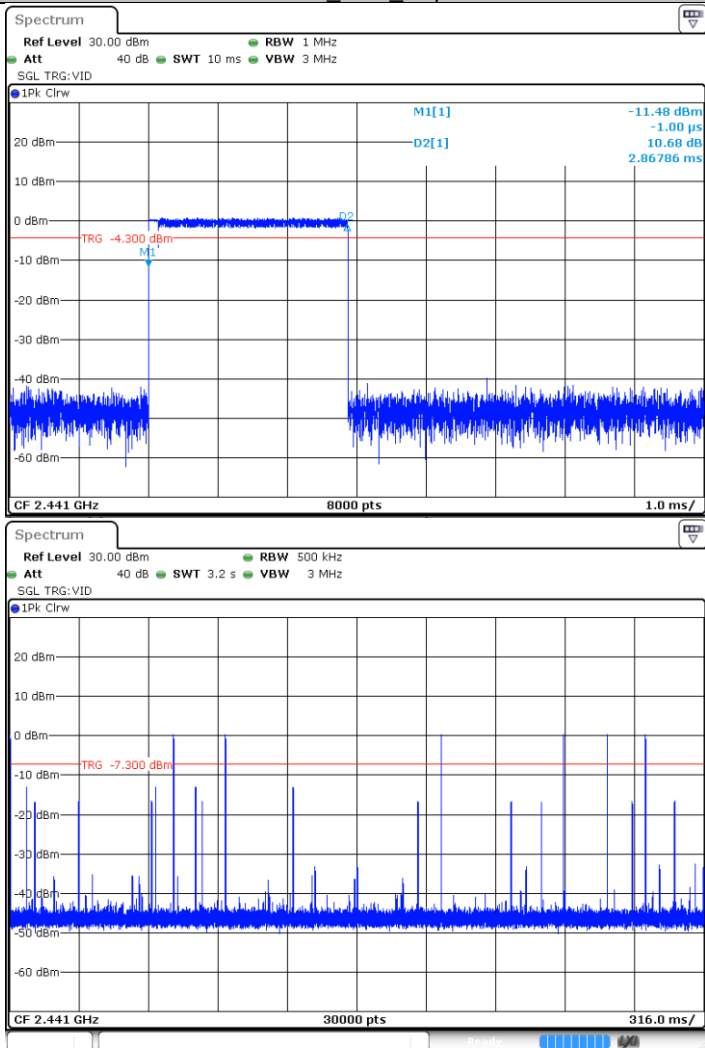
The Dwell Time = Burst Width * Total Hops. The detailed calculations are showed as follows:
The duration for dwell time calculation: 0.4 [s] * hopping number = 0.4 [s] * 79 [ch] = 31.6 [s*ch];

Test Result

TestMode	Channel	BurstWidth(ms)	TotalHops(N)	Result(s)	Limit(s)	Verdict
DH5	Hop	2.86	80	0.229	<=0.4	PASS
2DH5	Hop	2.87	70	0.201	<=0.4	PASS



2DH5_Ant1_Hop



Date: 7.JAN.2021 15:22:28

9.6 Spurious RF conducted emissions

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peak level of the in-band emission and all spurious emissions (e.g., harmonics) from the lowest frequency generated in the EUT up through the 10th harmonic. Typically, several plots are required to cover this entire span.
RBW = 100 kHz, VBW ≥ RBW, Sweep = auto, Detector function = peak, Trace = max hold
2. Allow the trace to stabilize. Set the marker on the peak of any spurious emission recorded.
3. The level displayed must comply with the limit specified in this Section. Submit these plots.
4. Repeat above procedures until all frequencies measured were complete.

Limit

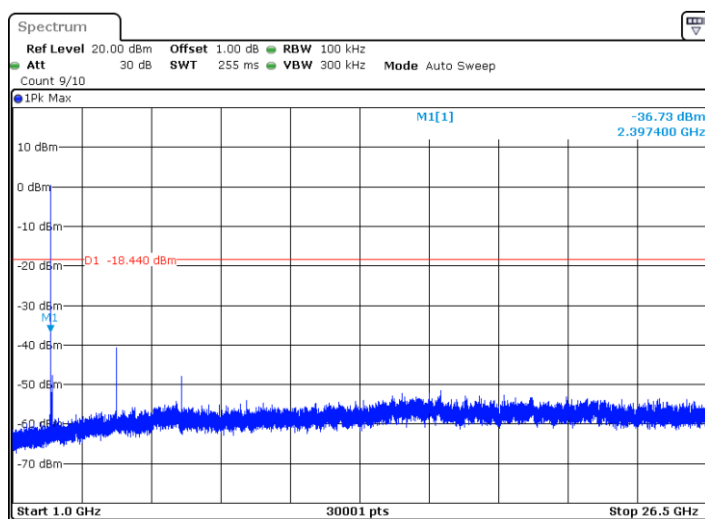
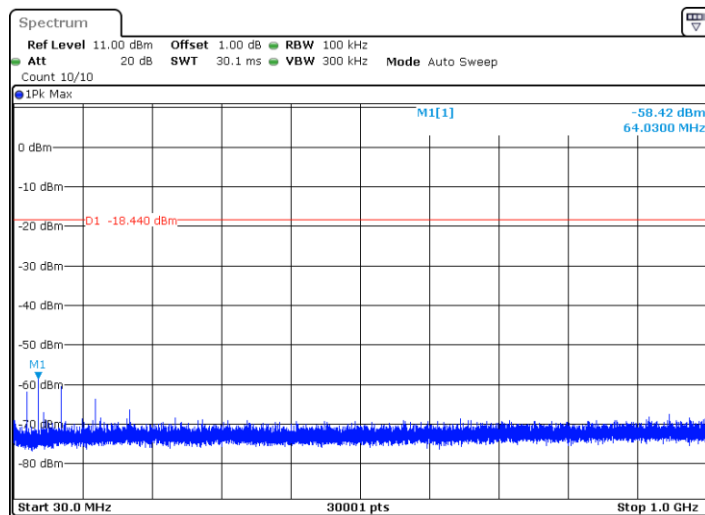
Frequency Range MHz	Limit (dBc)
30-25000	-20

Spurious RF conducted emissions

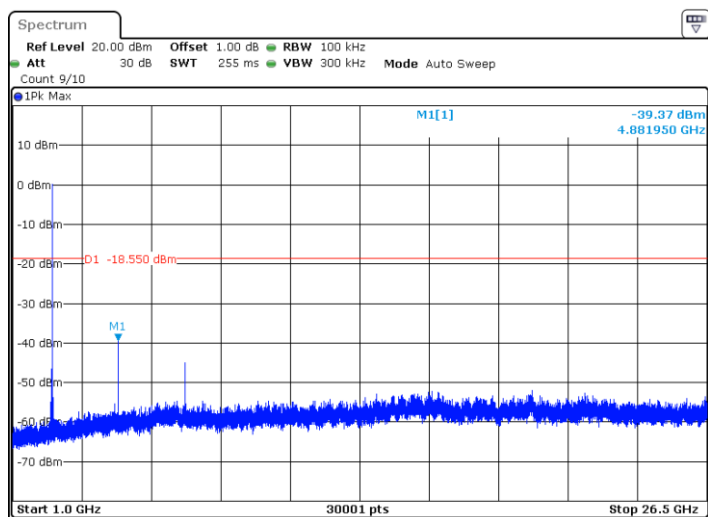
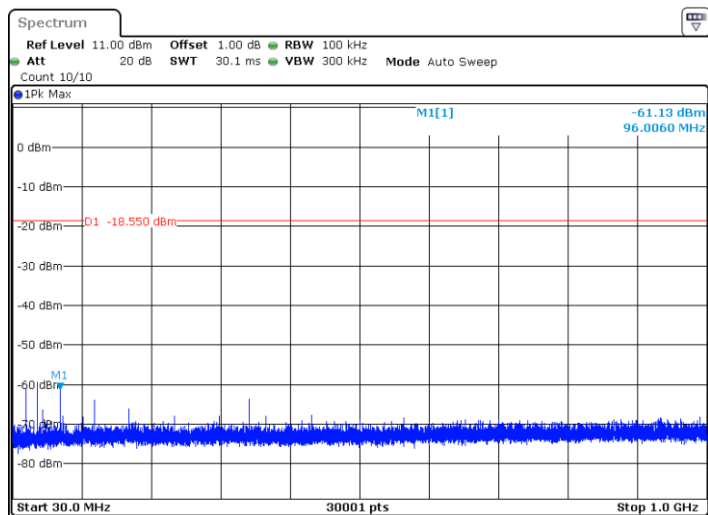
Test graphs

DH5

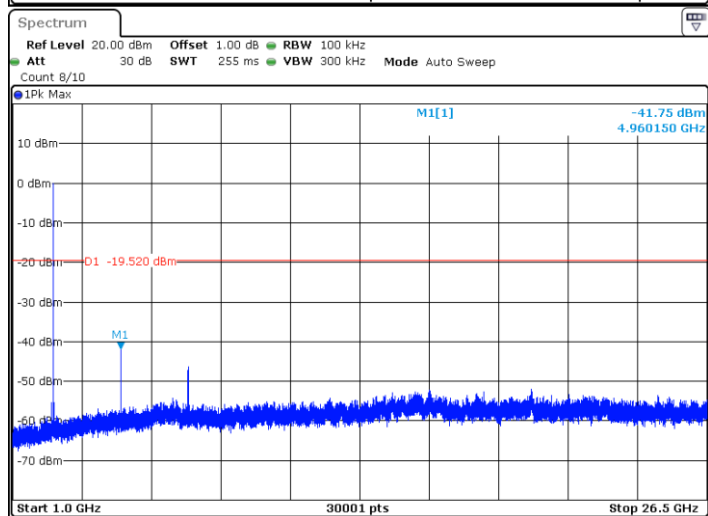
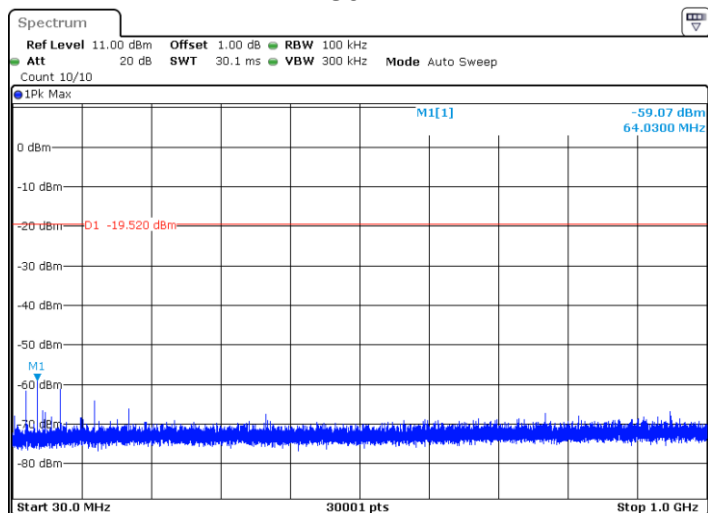
2402MHz



2441MHz

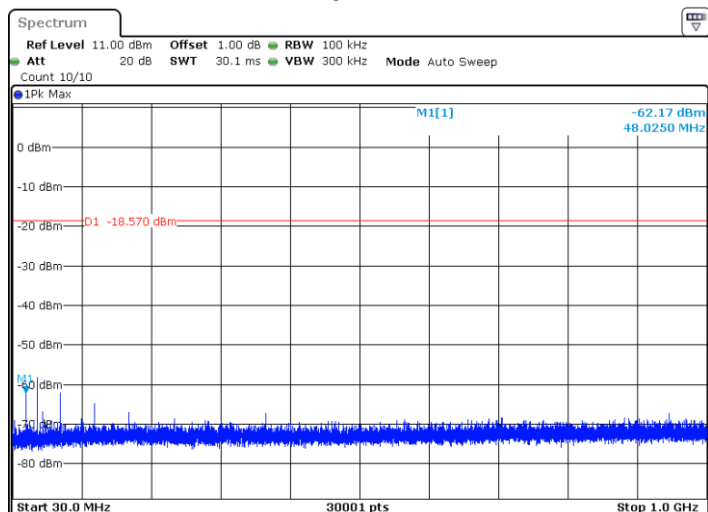


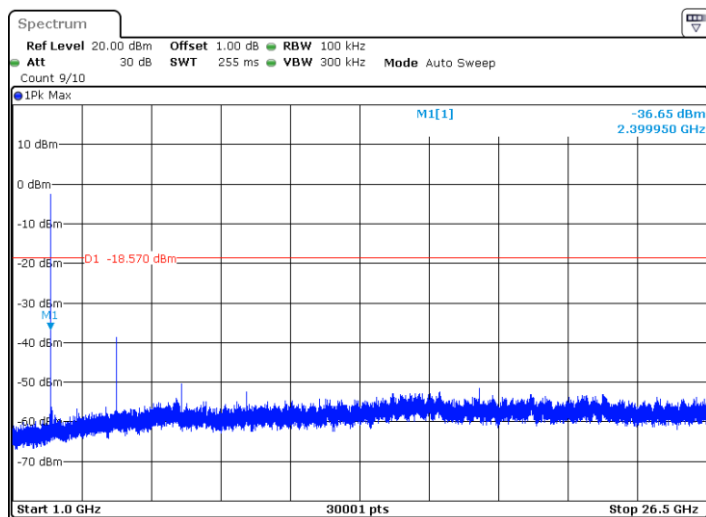
2480MHz



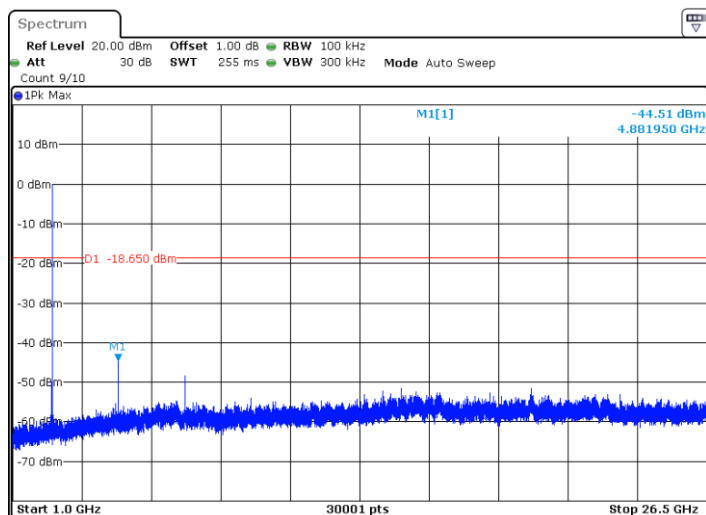
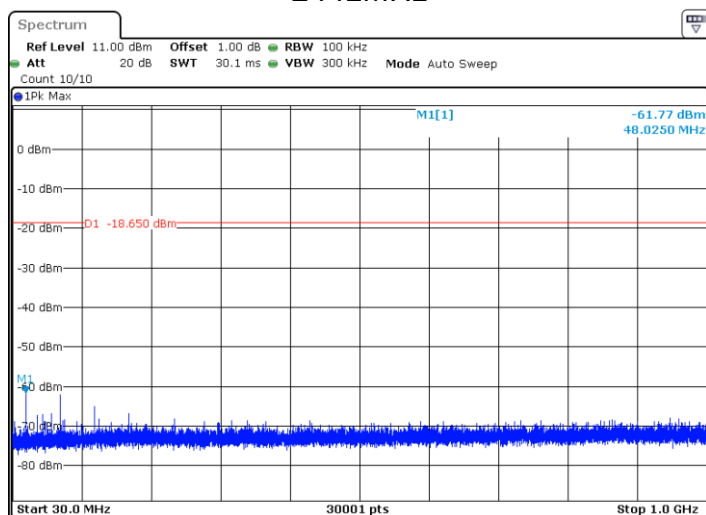
2DH5

2402MHz

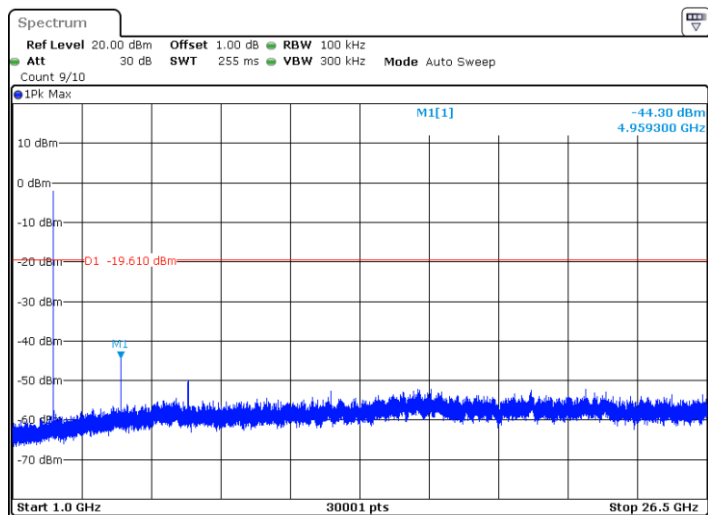
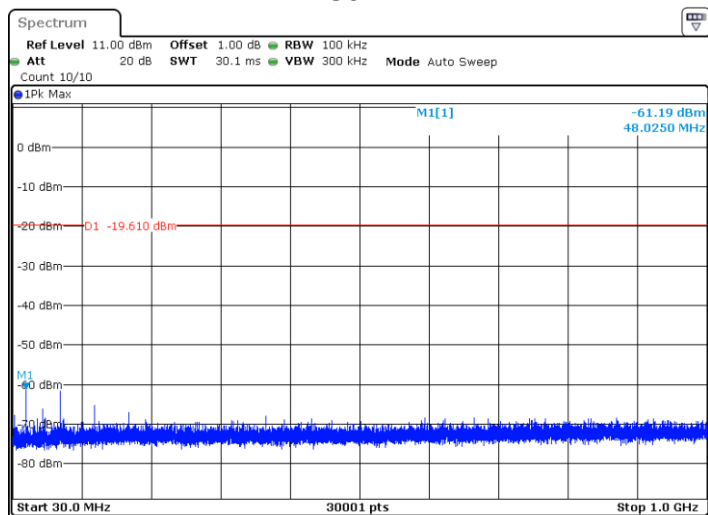




2441MHz



2480MHz



9.7 Band edge testing

Test Method

- 1 Use the following spectrum analyzer settings:
Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 100 kHz, VBW $\geq$ RBW, Sweep = auto, Detector function = peak, Trace = max hold
- 2 Allow the trace to stabilize, use the peak and delta measurement to record the result.
- 3 The level displayed must comply with the limit specified in this Section. .
- 4 Repeat the test at the hopping off and hopping on mode, submit all the plots.

Limit:

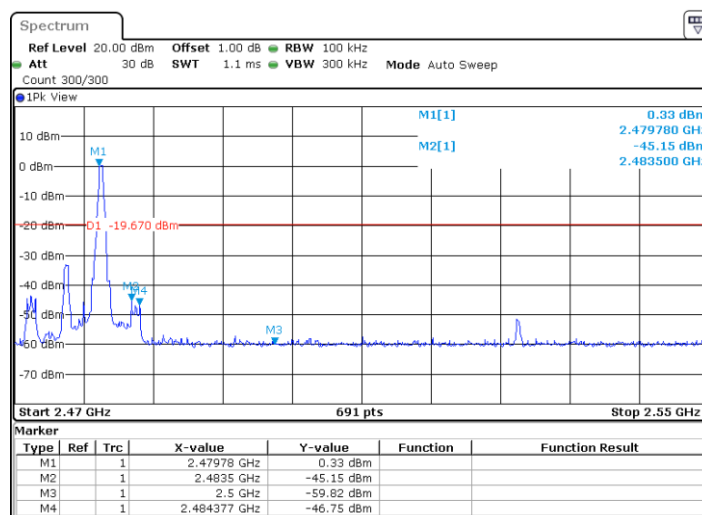
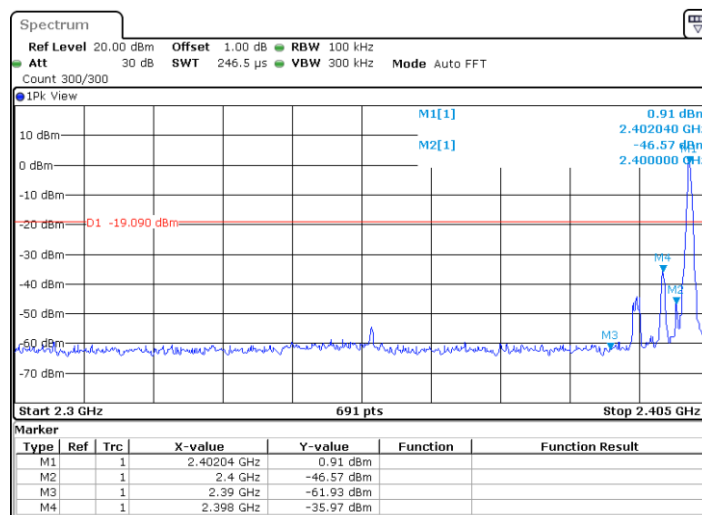
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits.

TestMode	ChName	Channel (MHz)	RefLevel (dBm)	Result(dBm)	Limit(dBm)	Verdict
DH5	Low	2402	0.91	-35.97	<=-19.09	PASS
	High	2480	0.33	-46.75	<=-19.67	PASS
	Low	Hop_2402	0.77	-55.47	-19.23	PASS
	High	Hop_2480	0.61	-52.02	-19.39	PASS
2DH5	Low	2402	-0.39	-36.99	<=-20.39	PASS
	High	2480	0.36	-46.5	<=-19.64	PASS
	Low	Hop_2402	0.29	-57.69	-19.71	PASS
	High	Hop_2480	0.52	-52.39	-19.48	PASS

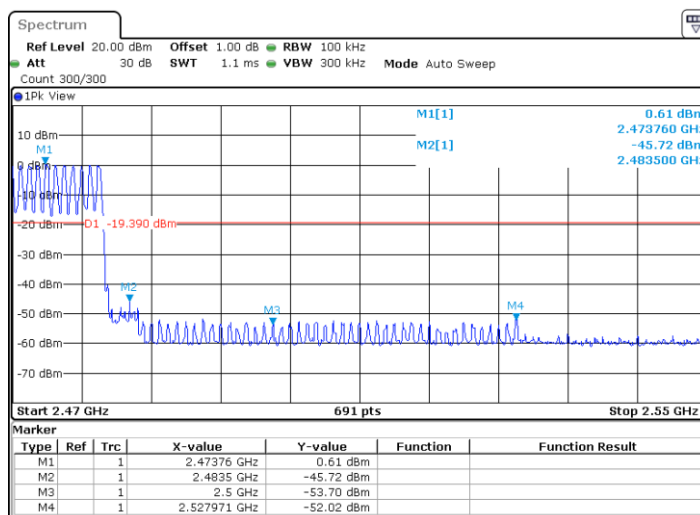
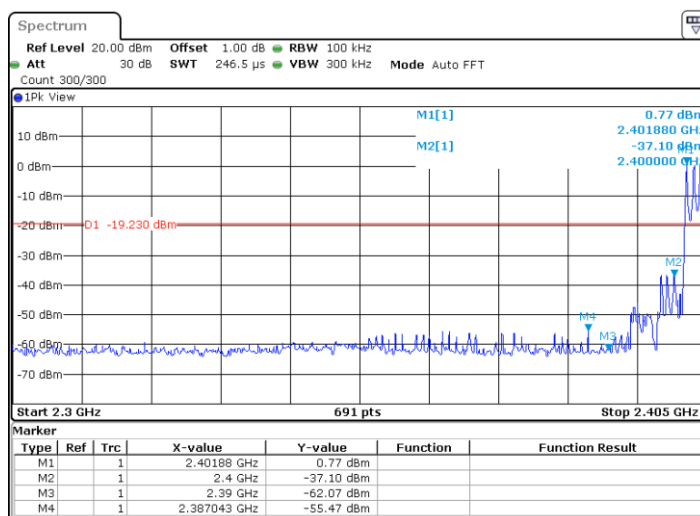
Test Graphs

GFSK Modulation Test Result:

Hopping on mode:

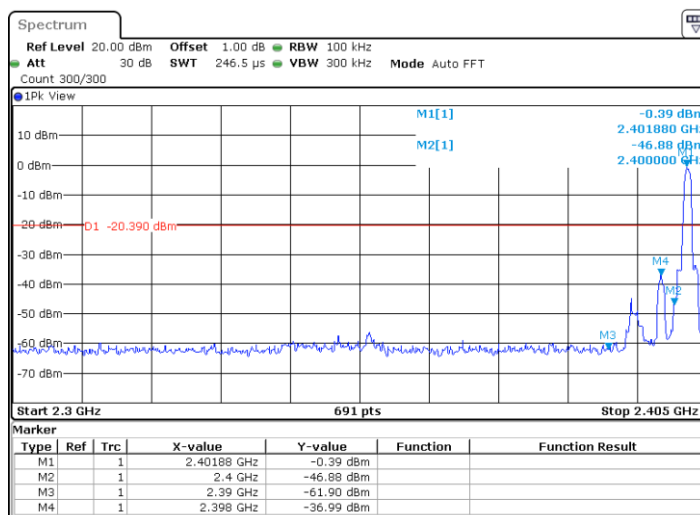


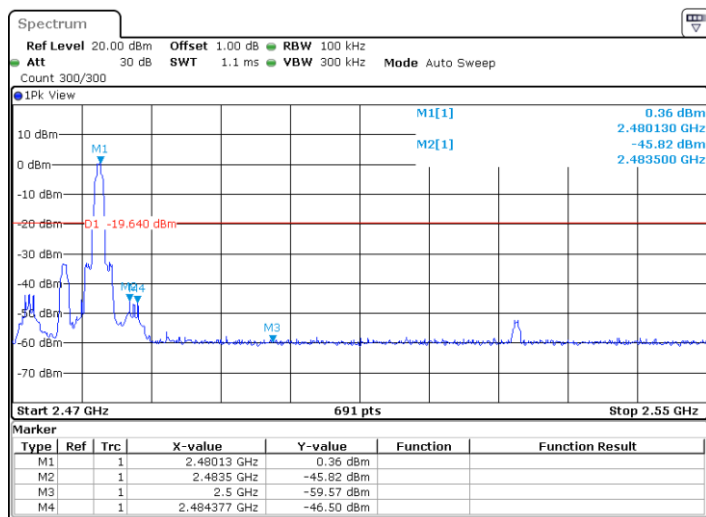
Hopping off mode:



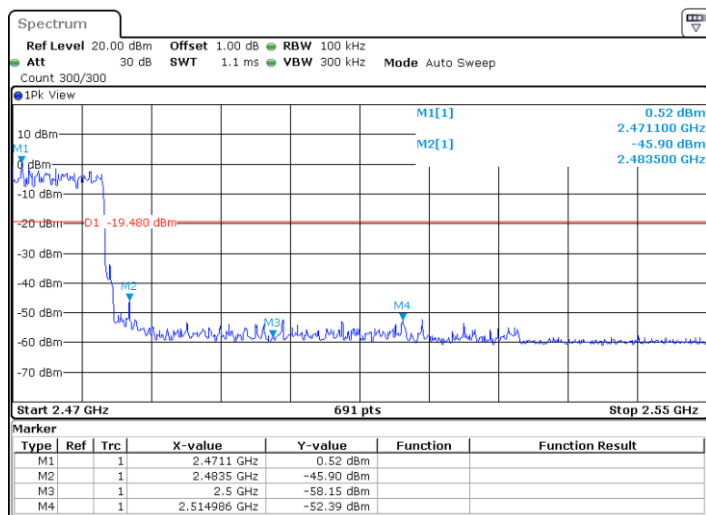
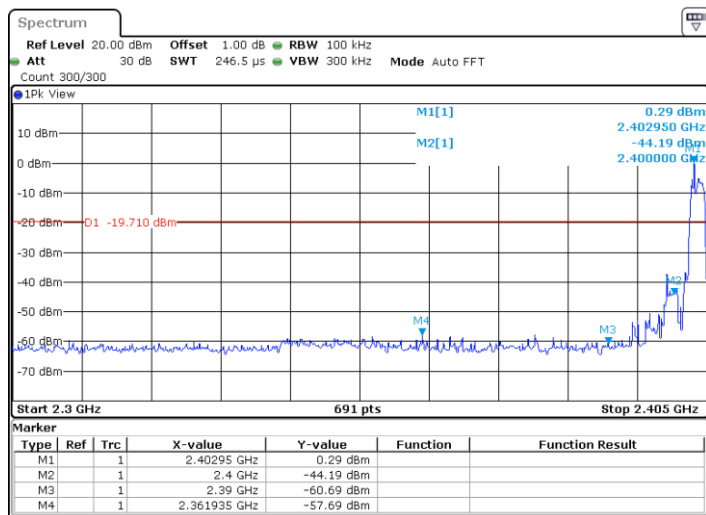
$\pi/4$ -DQPSK Modulation Test Result:

Hopping on mode:





Hopping off mode:



9.8 Spurious radiated emissions for transmitter

Test Method

- 1: The EUT was placed on a turn table which is 1.5m above ground plane for above 1GHz and 0.8m above ground for below 1GHz at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- 2: The EUT was set 3 meters away from the interference – receiving antenna, which was mounted on the top of a variable – height antenna tower.
- 3: The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 4: For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- 5: Use the following spectrum analyzer settings According to C63.10:

For Below 1GHz

Use the following spectrum analyzer settings:

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 100 KHz to 120KHz, VBW $\geq$ RBW for peak measurement, Sweep = auto,
Detector function = peak, Trace = max hold.

For Peak unwanted emissions Above 1GHz:

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 1MHz, VBW $\geq$ RBW for peak measurement, Sweep = auto,
Detector function = peak, Trace = max hold.

Procedures for average unwanted emissions measurements above 1000 MHz:

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 1MHz, VBW=10Hz, Sweep = auto, Detector function = peak, Trace = max hold.
If the dwell time per channel of the hopping signal is less than 100 ms, then the reading obtained with the 10 Hz VBW may be further adjusted by a “duty cycle correction factor”, derived from $20\log(\text{dwell time}/100 \text{ ms})$, in an effort to demonstrate compliance with the 15.209 limit.

If the emission is pulsed, modify the unit for continuous operation; use the settings shown above, then correct the reading by subtracting the peak-average correction factor, derived from the appropriate duty cycle calculation.

The setting method can refer to DA00-705.

Limit

The radio emission outside the operating frequency band shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power. Radiated emissions which fall in the restricted bands, as defined in section 15.205, must comply with the radiated emission limits specified in section 15.209.

Frequency MHz	Field Strength uV/m	Field Strength dBμV/m	Detector
30-88	100	40	QP
88-216	150	43.5	QP
216-960	200	46	QP
960-1000	500	54	QP
Above 1000	500	54	AV
Above 1000	5000	74	PK

Spurious radiated emissions for transmitter

According to C63.10, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement, so AV emission value did not show in below table if the peak value complies with average limit.

Transmitting spurious emission test result as below:

Below 1G:
30MHz-1GHz

Final Result

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
59.645625	34.04	40.00	5.96	H	16.90
168.770625	39.76	43.50	3.74	H	13.55
60.130625	35.47	40.00	4.53	V	16.81
163.011250	40.89	43.50	2.61	V	13.29

Above 1G: GFSK Modulation 2402MHz Test Result

Final Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
2454.500000	51.55	74.00	22.45	H	-3.02
3507.500000	46.88	74.00	27.12	H	-0.28
4324.000000	49.58	74.00	24.42	H	2.04
5134.000000	49.37	74.00	24.63	H	3.68
7206.500000	50.76	54.00	3.24	H	5.12

Final Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
2402.000000	50.54	74.00	23.46	V	-3.13
2442.500000	56.02	74.00	17.98	V	-3.08
3078.500000	46.84	74.00	27.16	V	-1.23
4526.000000	49.72	74.00	24.28	V	2.43
7206.500000	47.73	54.00	6.27	V	5.12

GFSK Modulation 2441MHz Test Result

Final Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
1928.500000	42.34	74.00	31.66	H	-4.52
2402.500000	53.03	74.00	20.97	H	-3.13
3769.000000	48.33	74.00	25.67	H	0.57
4366.000000	49.63	74.00	24.37	H	2.11
7322.500000	49.44	54.00	4.56	H	5.30

Critical Freqs

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
2443.000000	50.61	74.00	23.39	V	-3.08
2480.000000	51.50	74.00	22.50	V	-2.91

4212.000000	49.12	74.00	24.88	V	1.78
5131.000000	50.53	74.00	23.47	V	3.66
7206.500000	47.73	54.00	6.27	V	5.12
7323.000000	46.04	74.00	27.96	V	5.30
9513.500000	42.19	74.00	31.81	V	7.57
11247.500000	44.04	74.00	29.96	V	8.45
14307.500000	46.00	74.00	28.00	V	10.80
16115.500000	48.36	74.00	25.64	V	14.71

GFSK Modulation 2480MHz Test Result

Final Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
1979.000000	42.32	74.00	31.68	H	-4.21
2528.000000	45.49	74.00	28.51	H	-2.86
3264.500000	46.96	74.00	27.04	H	-0.84
4854.000000	50.70	74.00	23.30	H	2.82
7440.000000	50.40	54.00	3.60	H	5.49

Final Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
2176.500000	43.84	74.00	30.16	V	-3.78
2864.500000	45.70	74.00	28.30	V	-1.83
3822.000000	49.41	74.00	24.59	V	0.74
5162.500000	50.08	74.00	23.92	V	3.85
7440.000000	46.55	54.00	7.45	V	5.49

π/4-DQPSK Modulation 2402MHz Test Result

Final_Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
2393.500000	50.29	74.00	23.71	H	-3.15
2444.500000	49.94	74.00	24.06	H	-3.07
3605.000000	47.60	74.00	26.40	H	0.06
5454.000000	50.74	74.00	23.26	H	4.24
7206.000000	47.08	54.00	6.92	H	5.12

Final_Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
1928.500000	43.03	74.00	30.97	V	-4.52
2458.500000	48.65	74.00	25.35	V	-3.00
3751.500000	47.52	74.00	26.48	V	0.54
4848.500000	50.91	74.00	23.09	V	2.82
7205.000000	46.86	74.00	27.14	V	5.11
8295.000000	42.78	74.00	31.23	V	6.37
10067.500000	44.82	74.00	29.18	V	9.29
16113.000000	49.03	74.00	24.97	V	14.72

π/4-DQPSK Modulation 2441MHz Test Result

Final_Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
2443.500000	49.66	74.00	24.34	H	-3.08
2653.500000	50.58	74.00	23.42	H	-2.46
4085.000000	49.36	74.00	24.64	H	1.54
5117.500000	49.67	74.00	24.33	H	3.57
7323.000000	45.98	54.00	8.02	H	5.30

Final_Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
1703.500000	42.58	74.00	31.42	V	-6.49
2800.000000	46.12	74.00	27.88	V	-2.05
3893.500000	47.66	74.00	26.34	V	1.01
5213.500000	49.66	74.00	24.34	V	3.42
7323.500000	45.51	74.00	28.49	V	5.30
9447.000000	42.53	74.00	31.47	V	7.49
12549.000000	44.60	74.00	29.40	V	9.26
16968.000000	48.67	74.00	25.33	V	16.44

π/4-DQPSK Modulation 2480MHz Test Result

Final Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
1921.000000	41.72	74.00	32.28	H	-4.68
2528.000000	46.06	74.00	27.94	H	-2.86
4023.500000	48.42	74.00	25.58	H	1.35
5297.000000	50.97	74.00	23.03	H	3.73
7439.500000	46.53	54.00	7.47	H	5.49

Final Result

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Pol	Corr. (dB/m)
2102.000000	43.38	74.00	30.62	V	-4.04
2988.000000	46.60	74.00	27.40	V	-1.53
4344.000000	49.68	74.00	24.32	V	2.06
4820.000000	50.70	74.00	23.30	V	2.82
7440.000000	44.95	74.00	29.05	V	5.49
9065.500000	42.19	74.00	31.81	V	6.79
10523.500000	44.28	74.00	29.72	V	8.56
16987.000000	48.91	74.00	25.09	V	16.41

Remark:

- (1) Data of measurement within frequency range 18-26GHz are the noise floor or attenuated more than 20dB below the permissible limits or the field strength is too small to be measured, so test data does not present in this report;
- (2) Level=Reading Level + Correction Factor
 Above 1GHz: Corrector factor = Antenna Factor + Cable Loss- Amplifier Gain
 Below 1GHz: Corrector factor = Antenna Factor + Cable Loss

10 Test Equipment List

List of Test Instruments

Radiated Emission Test

Description	Manufacturer	Model no.	Serial no.	cal. due date
Signal Analyzer	Rohde & Schwarz	FSV40	101031	2021-6-28
Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9163	708	2021-7-5
Horn Antenna	Rohde & Schwarz	HF907	102295	2021-7-5
Wideband Horn Antenna	Q-PAR	QWH-SL-18-40-K-SG	12827	2021-7-5
Loop Antenna	Rohde & Schwarz	HFH2-Z2	100398	2021-7-7
Pre-amplifier	Rohde & Schwarz	SCU 18	102230	2021-6-28
Pre-amplifier	Rohde & Schwarz	SCU 40A	100432	2021-7-16
Attenuator	Agilent	8491A	2021-6-21	Attenuator
Fully Anechoic Chamber	TDK	8X4X4	--	2020-7-7
Test software	Rohde & Schwarz	EMC32	Version 9.15.00	N/A

Conducted Emission Test

Description	Manufacturer	Model no.	Serial no.	cal. due date
EMI Test Receiver	Rohde & Schwarz	ESR 3	101782	2021-6-29
LISN	Rohde & Schwarz	ENV4200	100249	2021-6-12
LISN	Rohde & Schwarz	ENV432	101318	2021-6-12
LISN	Rohde & Schwarz	ENV216	100326	2021-6-12
ISN	Rohde & Schwarz	ENY81	100177	2021-6-12
ISN	Rohde & Schwarz	ENY81-CA6	101664	2021-6-12
High Voltage Probe	Schwarzbeck	TK9420(VT9420)	9420-584	2021-6-23
RF Current Probe	Rohde & Schwarz	EZ-17	100816	2021-6-28
Attenuator	Shanghai Huaxiang	TS2-26-3	080928189	2021-6-21
Test software	Rohde & Schwarz	EMC32	Version9.15.00	N/A
Shielding Room	TDK	CSR #1	----	2022-11-07

RF Test System

Description	Manufacturer	Model no.	Serial no.	cal. due date
Signal Generator	Rohde & Schwarz	SMB100A	108272	2021-6-21
Vector Signal Generator	Rohde & Schwarz	SMBV100A	262825	2021-6-21
Communication Synthetical Test Instrument	Rohde & Schwarz	CMW 270	101251	2021-6-21
Signal Analyzer	Rohde & Schwarz	FSV40	101030	2021-6-21
Vector Signal Generator	Rohde & Schwarz	SMU 200A	105324	2021-6-22
RF Switch Module	Rohde & Schwarz	OSP120/OSP-B157	101226/100851	2021-6-21
Power Splitter	Weinschel	1580	SC319	2021-7-16
10dB Attenuator	Weinschel	4M-10	43152	2021-6-21
10dB Attenuator	R&S	DNF	DNF-001	2021-6-21
10dB Attenuator	R&S	DNF	DNF-002	2021-6-21
10dB Attenuator	R&S	DNF	DNF-003	2021-6-21
10dB Attenuator	R&S	DNF	DNF-004	2021-6-21
Test software	Rohde & Schwarz	EMC32	Version 10.60.10	N/A
Test software	Tonscend	System for BT/WIFI	Version 2.6.77.0518	N/A
Shielding Room	TDK	TS8997	----	2022-11-07

11 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

System Measurement Uncertainty	
Test Items	Extended Uncertainty
Uncertainty for Conducted Emission 150kHz-30MHz (for test using AMN ENV432 or ENV4200)	3.21dB
Uncertainty for Radiated Emission in 3m chamber 30MHz-1000MHz	Horizontal: 4.63dB; Vertical: 4.61dB;
Uncertainty for Radiated Emission in 3m chamber 1000MHz-18000MHz	Horizontal: 4.65dB; Vertical: 4.64dB;
Uncertainty for Radiated Spurious Emission 25MHz-3000MHz	Horizontal: 4.35dB; Vertical: 4.44dB;
Uncertainty for Radiated Spurious Emission 3000MHz-18000MHz	Horizontal: 4.30dB; Vertical: 4.29dB;
Uncertainty for Radiated Spurious Emission 18000MHz-40000MHz	Horizontal: 4.51dB; Vertical: 4.50dB;
Uncertainty for Conducted RF test with TS 8997	RF Power Conducted: 1.31dB Frequency test involved: 0.6×10^{-7} or 1%